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Certified Reference Material

Certificate of Analysis

Revision No.: 001

Product ID: MBH-13X 18004 C

ISO 17034:2016 ISO/IEC 17025:2017

Revision Date: 02/17/2022



Product Description: Austenitic Stainless Steel

Description and Intended Use: This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

			Ce	ertified Val	ues listed in w	t.% with a	ssociated (uncertainties	;			
Αl	0.011	± 0.002	С	0.0430	± 0.0009	Co	0.168	± 0.003		Cr	21.62	± 0.09
Cu	0.048	± 0.003	Mn	1.57	± 0.02	Мо	0.562	± 0.005		N	0.0225	± 0.0009
Nb	0.748	± 0.009	Ni	12.26	± 0.06	Р	0.0060	± 0.0006		S	0.0063	± 0.0009
Si	1.21	± 0.02	Sn	0.0025	± 0.0007	Ti	0.095	± 0.004		٧	0.152	± 0.002
W	0.004	± 0.001										
					Indicative '	Values lis	ted in ppn	n				
	As (4	40) B	(<4)	Fe (6	S1 3%) N	/a (<30) ()	(<40)	Ph	(10)	Sh	(9)

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1.
$$N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$
 2. $U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

LGC Standards - Manchester, NH

Zr

(10)

- Connecticut Metallurgical, Inc. East Hartford, CT
- IMR Test Labs Lansing, NY
- NSL Analytical Services Cleveland, OH
- SGS MSi Melrose Park, IL
- Cleveland Cliffs Middletown, OH
- Applied Technical Services Marietta, GA
- EAG Laboratories Liverpool, NY
- Sheffield Assay Office Sheffield, UK
- Scrooby's Laboratory Service Rynfield, South Africa
- Element Materials Technology Middlesbrough, UK
- New Hampshire Materials Laboratory Somersworth, NH
- RSML Bengaluru, India

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Kimberly Halfriotis, Global Product Manager

February 17, 2022 Certification Date



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01



The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Al	As	В	С	Co	Cr	Cu	Fe	Mg	Mn	Мо	N	Nb
1	0.0090	0.0009	0.0002	0.0410	0.1580	21.320	0.0380	61.000	0.0021	1.5040	0.5460	0.0207	0.7260
2	0.0055	0.0016	0.0003	0.0410	0.1580	21.350	0.0400	61.130	0.0030	1.5210	0.5480	0.0210	0.7280
3	0.0064	0.0021	0.0007	0.0420	0.1590	21.375	0.0410	61.250	<0.0005	1.5230	0.5500	0.0220	0.7380
4	0.0080	0.0027		0.0420	0.1651	21.451	0.0420	61.540	<0.0005	1.5360	0.5510	0.0227	0.7390
5	0.0090	0.0030		0.0425	0.1660	21.470	0.0431	61.720	<0.001	1.5525	0.5590	0.0230	0.7400
6	0.0090	0.0058		0.0430	0.1680	21.480	0.0440		<0.0010	1.5530	0.5590	0.0230	0.7416
7	0.0090	0.0112		0.0433	0.1680	21.495	0.0450		<0.0010	1.5600	0.5590	0.0232	0.7460
8	0.0096	<0.0005		0.0437	0.1690	21.500	0.0460		<0.005	1.5656	0.5590	0.0240	0.7500
9	0.0099	<0.002		0.0438	0.1690	21.584	0.0470		<0.01	1.5686	0.5606		0.7500
10	0.0101	< 0.002		0.0439	0.1690	21.625	0.0483			1.5690	0.5618		0.7520
11	0.0103	<0.005		0.0449	0.1698	21.660	0.0489			1.5720	0.5620		0.7524
12	0.0106	<0.005		0.0450	0.1704	21.697	0.0490			1.5790	0.5633		0.7591
13	0.0116	<0.005			0.1720	21.706	0.0500			1.5800	0.5684		0.7630
14	0.0130				0.1740	21.726	0.0500			1.5870	0.5700		0.7670
15	0.0140				0.1742	21.742	0.0510			1.5890	0.5760		0.7730
16	0.0150				0.1760	21.848	0.0510			1.5980	0.5770		
17	0.0150				0.1770	21.860	0.0520			1.6020	0.5820		
18	0.0156					21.900	0.0545			1.6060			
19	<0.01					21.990	0.0580			1.6220			
20							0.0580			1.6280			
Mean	0.0106	0.0039	0.0004	0.0430	0.1684	21.620	0.0478	61.328	0.0026	1.5708	0.5619	0.0225	0.7483
STDV	0.0029	0.0036	0.0003	0.0013	0.0058	0.1959	0.0056	0.2964	0.0006	0.0331	0.0103	0.0011	0.0135
Certified	0.011	(0.004)	(<0.0004)	0.0430	0.168	21.62	0.048	(61.3)	(<0.003)	1.57	0.562	0.0225	0.748
Ucrm	0.002			0.0009	0.003	0.09	0.003			0.02	0.005	0.0009	0.009
Methods	I,O,G,IM,X	IM,I,X,O	IM,O,I	C,O	I,O,G,IM,X	O,I,G,X	I,O,G,IM,X	I,O,X	I,O,IM	I,O,G,X	I,O,G,X	F	I,O,G,X

	Ni	0	Р	Pb	S	Sb	Si	Sn	Ti	٧	W	Zr
1	12.095	0.0040	0.0039	0.0002	0.0047	0.0003	1.1410	0.0010	0.0830	0.1460	0.0020	0.0018
2	12.109	0.0048	0.0046	0.0003	0.0048	0.0005	1.1520	0.0013	0.0850	0.1460	0.0020	0.0001
3	12.130		0.0050	0.0018	0.0050	0.0010	1.1660	0.0020	0.0860	0.1470	0.0024	0.0013
4	12.139		0.0050	0.0026	0.0056	0.0013	1.1750	0.0020	0.0890	0.1500	0.0035	0.0018
5	12.150		0.0050	<0.0010	0.0059	0.0015	1.1750	0.0021	0.0906	0.1500	0.0045	<0.0005
6	12.173		0.0052	<0.0010	0.0060	<0.0010	1.1770	0.0027	0.0910	0.1500	0.0050	<0.0010
7	12.207		0.0060	<0.002	0.0060	<0.002	1.1810	0.0029	0.0913	0.1510	0.0050	< 0.002
8	12.270		0.0062	<0.002	0.0060	<0.01	1.1985	0.0031	0.0920	0.1510	0.0051	< 0.005
9	12.299		0.0065	<0.002	0.0060		1.2040	0.0035	0.0934	0.1520	0.0055	< 0.005
10	12.300		0.0070	<0.005	0.0062		1.2067	0.0041	0.0960	0.1530	0.0056	<0.01
11	12.300		0.0070		0.0064		1.2180	<0.001	0.0961	0.1530	<0.0005	<0.01
12	12.320		0.0070		0.0066		1.2290	<0.0010	0.0970	0.1540	<0.001	
13	12.321		0.0070		0.0070		1.2370	<0.002	0.0985	0.1540	<0.005	
14	12.334		0.0071		0.0070		1.2400	<0.002	0.1010	0.1550	<0.01	
15	12.334		0.0073		0.0077		1.2420	<0.002	0.1010	0.1570		
16	12.370		< 0.0050		0.0091		1.2440	<0.005	0.1030	0.1570		
17	12.410						1.2550	<0.005	0.1050			
18	12.480						1.2690	<0.01	0.1060			
19							1.2840		0.1060			
20												
Mean	12.263	0.0044	0.0060	0.0012	0.0063	0.0009	1.2102	0.0025	0.0953	0.1516	0.0041	0.0012
STDV	0.1111	0.0006	0.0011	0.0012	0.0011	0.0005	0.0407	0.0010	0.0071	0.0034	0.0015	0.0008
Certified	12.26	(<0.004)	0.0060	(0.001)	0.0063	(0.0009)	1.21	0.0025	0.095	0.152	0.004	(0.001)
U _{CRM}	0.06		0.0006		0.0009		0.02	0.0007	0.004	0.002	0.001	
Methods	O,I,G,X	F	I,O,IM,X	IM,I,O,X	C,G,X,O,I	IM,X,O	I,O,G,X	I,O,IM,X	I,O,G,IM,X	I,O,IM,X	I,O,IM,X	I,O,IM,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES